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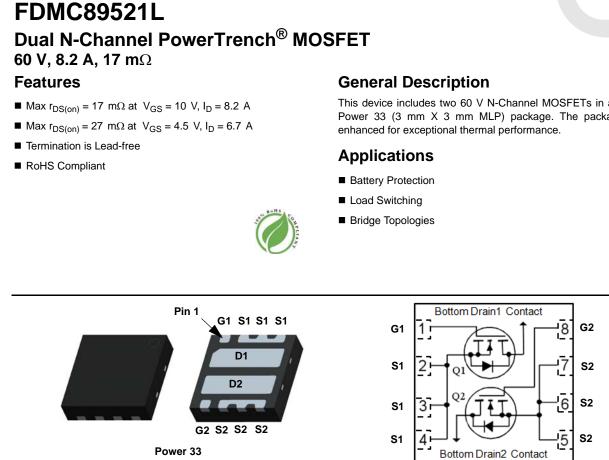


ON Semiconductor®

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Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (_), the underscore (_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.onsemi.com. Please email any questions regarding the system integration to Fairchild_questions@onsemi.com.

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MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted.

Symbol	Parameter			Ratings	Units	
V _{DS}	Drain to Source Voltage			60	V	
V _{GS}	Gate to Source Voltage			±20	V	
1	Drain Current -Continuous	T _A = 25 °C	(Note 1a)	8.2	٨	
D	-Pulsed			40	Α	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	32	mJ	
P _D	Power Dissipation	T _C = 25 °C		16	W	
	Power Dissipation	T _A = 25 °C	(Note 1a)	1.9	VV	
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C	

Thermal Characteristics

FAIRCHILD

R_{\thetaJC}	Thermal Resistance, Junction to Case	8.0	
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient (Note 1	a) 65	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient (Note 1	o) 155	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC89521L	FDMC89521L	Power 33	13 "	12 mm	3000 units

1

FDMC89521L Dual N-Channel PowerTrench[®] MOSFET

This device includes two 60 V N-Channel MOSFETs in a dual Power 33 (3 mm X 3 mm MLP) package. The package is

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Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Chara	octeristics					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	60			V
ΔBV_{DSS} ΔT_J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		30		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 48 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 V, V_{DS} = 0 V$			±100	nA
	cteristics					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \ \mu A$	1	1.9	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		-6		mV/°C
	$ \begin{array}{c} \mbox{Static Drain to Source On Resistance} \\ \mbox{Static Drain to Source On Resistance} \\ \end{array} \\ \begin{array}{c} \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 4.5 \ \mbox{V}, \ \mbox{I}_{D} = 6.7 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 8.2 \ \mbox{A} \\ \mbox{V}_{GS} = 10 \ \mbox{V}, \ \mbox{I}_{D} = 10 \ \mbox{V}_{S} \ \mbox{A} \\ \mbox{V}_{S} = 10 \ \mbox{V}_{S} \ \mbox{V}_{S} = 10 \ \mbox{V}_{S} \ \mbox{A} \ \mbox{V}_{S} = 10 \ \mbox{V}_{S} \ \mbox{A} \ $	V _{GS} = 10 V, I _D = 8.2 A		13	17	
		$V_{GS} = 4.5 V, I_D = 6.7 A$		21	27	mΩ
r _{DS(on)}		T _J = 125 °C		20	26	11152
9 _{FS}	Forward Transconductance	V _{DS} = 10 V, I _D = 8.2 A		28		S
Dynamic	Characteristics					
Ciss	Input Capacitance	<u> </u>		1228	1635	pF
C _{oss}	Output Capacitance	V _{DS} = 30 V, V _{GS} = 0 V, f = 1 MHz		243	325	pF
C _{rss}	Reverse Transfer Capacitance			10	15	pF
Rg	Gate Resistance			0.7		Ω
Switching	g Characteristics					
t _{d(on)}	Turn-On Delay Time			7.9	16	ns
t _r	Rise Time	V _{DD} = 30 V, I _D = 8.2 A,		2.1	10	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		18	33	ns
t _f	Fall Time			1.7	10	ns
Qg	Total Gate Charge	$V_{GS} = 0 V \text{ to } 10 V$		17	24	nC
Qg	Total Gate Charge	$V_{GS} = 0$ V to 4.5 V $V_{DD} = 30$ V,		7.9	12	nC
Q _{gs}	Gate to Source Charge	I _D = 8.2 A		3.8		nC
Q _{gd}	Gate to Drain "Miller" Charge			1.9		nC

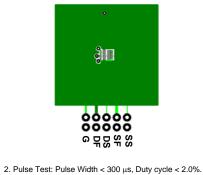
V _{SD}	Source-Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 8.2 A$ (Note 2)	0.85	1.3	V
		$V_{GS} = 0 V, I_S = 1.6 A$ (Note 2)	0.75	1.2	v
t _{rr}	Reverse Recovery Time	I _E = 8.2 A, di/dt = 100 A/μs	25	40	ns
Q _{rr}	Reverse Recovery Charge	$F = 0.2 \text{ A}, \text{ u/ut} = 100 \text{ A/}\mu\text{s}$	11	20	nC

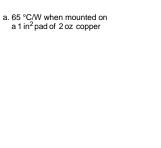
Notes:

1. R_{0,JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,JC} is guaranteed by design while R_{0CA} is determined by the user's board design.

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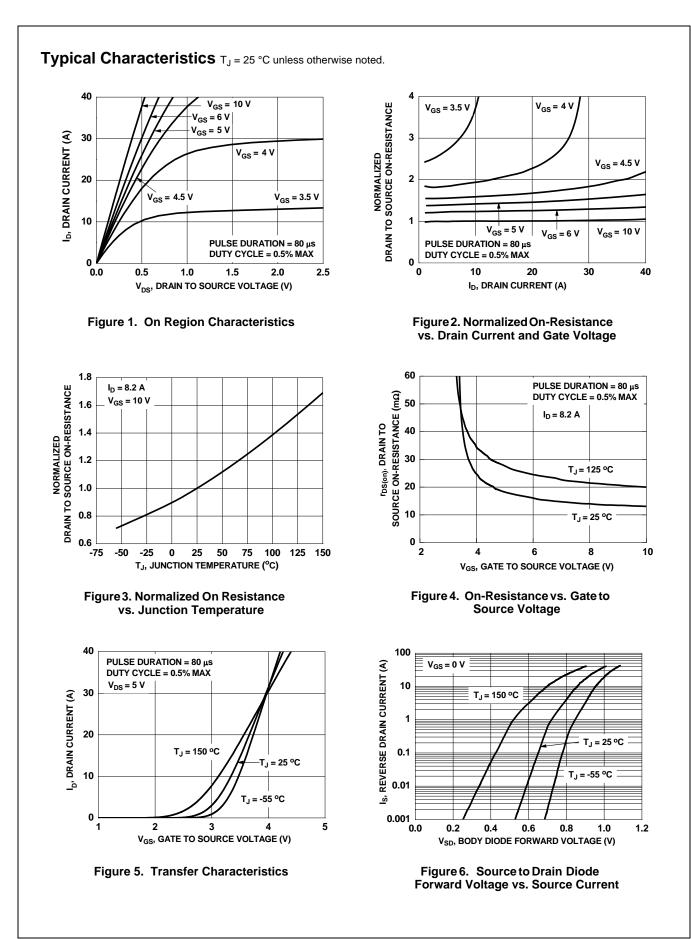


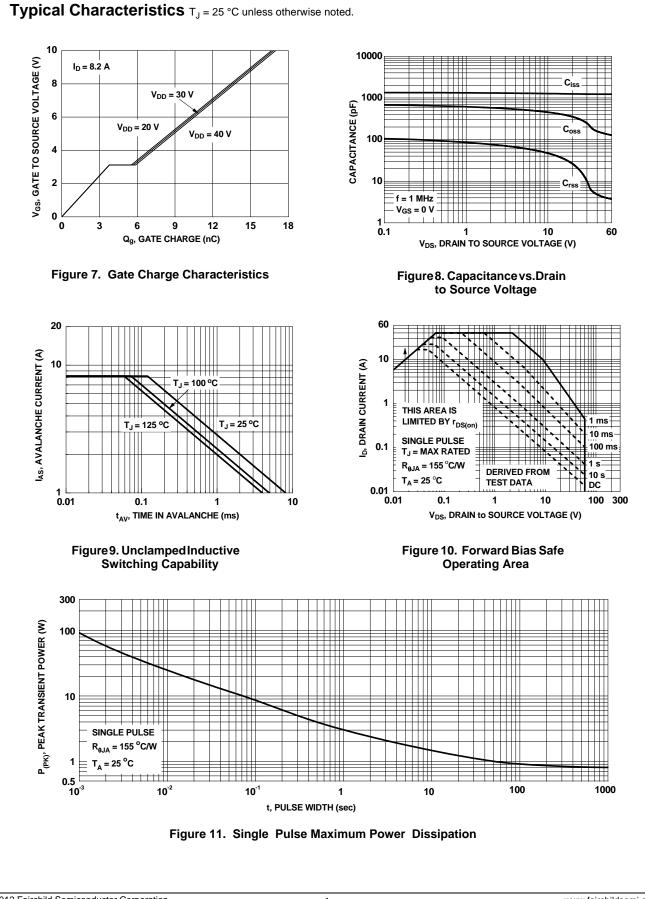


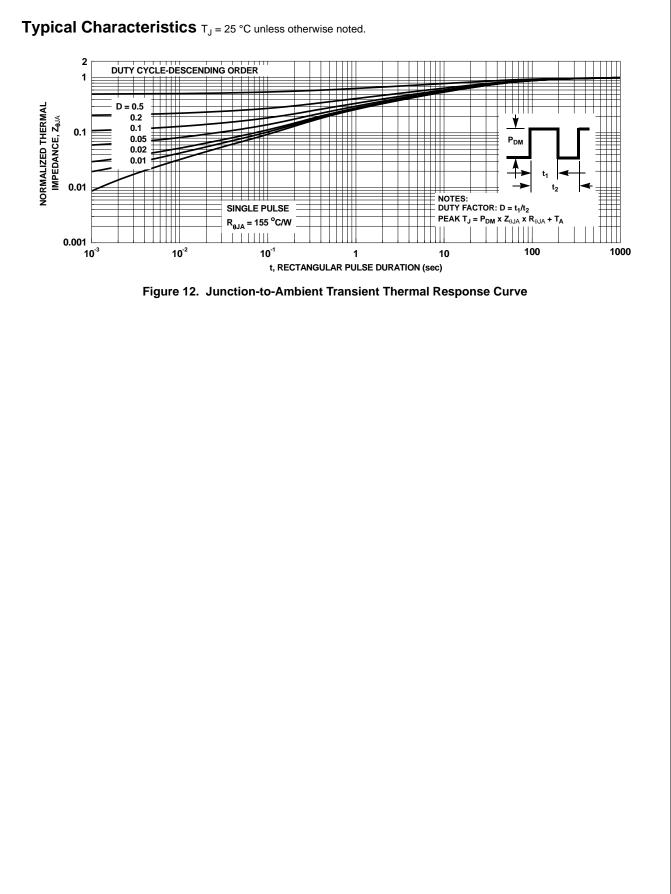
3. E_{AS} of 32 mJ is based on starting T_J = 25 °C, L = 1 mH, I_{AS} = 8 A, V_{DD} = 54 V, V_{GS} = 10 V. 100% tested at L = 3 mH, I_{AS} = 5.4 A.

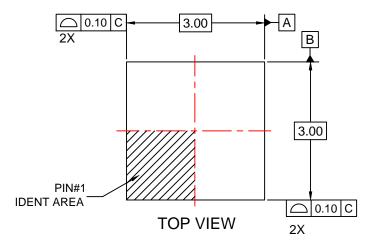
b. 155 °C/W when mounted on a minimum pad of 2 oz copper

FDMC89521L Dual N-Channel PowerTrench[®] MOSFET

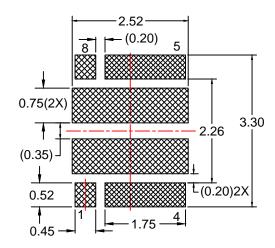








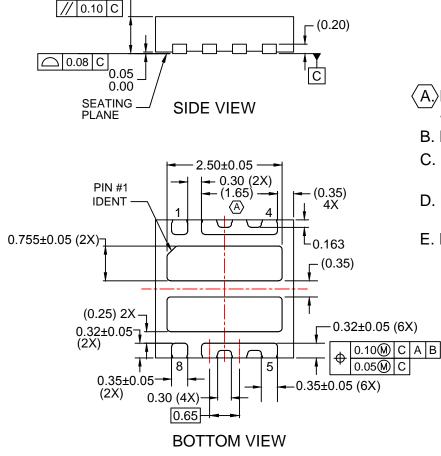
0.80 MAX



RECOMMENDED LAND PATTERN

NOTES:

- A DOES NOT FULLY CONFORM TO JEDEC REGISTRATION, MO-229.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994
- D. LAND PATTERN RECOMMENDATION IS BASED ON FSC DESIGN ONLY
- E. DRAWING FILE NAME: MKT-MLP08Xrev2.



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